

Sheet 1 of 1

# INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)

**U.S. APPLICATION NO.**  
**Not yet assigned**

**GROUP**

## U.S. PATENT DOCUMENTS

# FOREIGN PATENT DOCUMENTS

**OTHER ART** (Including Author, Title, Date, Pertinent Pages, Etc.)

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

6/6/05

Sheet 1 of 1

<b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b>  <b>(PTO-1449)</b>				ATTY. DOCKET NO. <b>KUD-004</b>		U.S. PATENT APPLICATION NO. <b>10/525,877</b>	
				APPLICANT <b>Shigemitsu KIKUCHI et al</b>			
				FILING DATE <b>02/17/05</b>		GROUP	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
<b>FOREIGN PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
<i>MC</i>	H08-061821 ✓	03/08/96	Japan			X	
<i>↑</i>	2003-302116 ✓	10/24/03	Japan			X	
	2003-083634 ✓	03/19/03	Japan			X	
	H07-091760 ✓	04/04/95	Japan			X	
	2001-123997 ✓	05/08/01	Japan			X	
	H11-055899 ✓	02/26/99	Japan			X	
	JP10267444 ✓	10/09/98	Japan			X	
	JP9178323 ✓	07/11/97	Japan			X	
	S56-18883 ✓	02/19/81	Japan				X
	H06-32123 ✓	04/26/94	Japan				X
	WO2005/011001 ✓	02/03/05	PCT			X	
	H11-132583 ✓	05/21/99	Japan			X	
<i>MC</i>	H05-106944 ✓	04/27/93	Japan			X	
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
EXAMINER				DATE CONSIDERED			
<i>McHein-At</i>				<i>09-10-07</i>			

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<b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)</b>				ATTY. DOCKET NO. KUD-004		U.S. PATENT APPLICATION NO. 10/524,877	
				APPLICANT Shigemitsu KIKUCHI et al			
				FILING DATE 02/17/05		GROUP	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
<b>FOREIGN PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
ML	2000-356425 ✓	12/26/2000	Japan			X	
ML	2002-120000 ✓	04/23/2002	Japan			X	
ML	H06-034212 ✓	02/08/1994	Japan			X	
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
EXAMINER	Md. Meher Ali			DATE CONSIDERED 09-10-07			

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